Depletion-Mode Power MOSFET

General Features

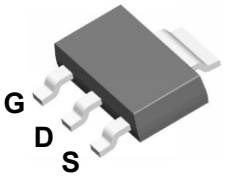
- ESD improved Capability
- Depletion Mode (Normally On)
- Proprietary Advanced Planar Technology
- Rugged Polysilicon Gate Cell Structure
- Fast Switching Speed
- RoHS Compliant
- Halogen-free available

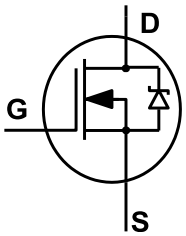
BV_{DSX}	$R_{DS(ON)}$ (Max.)	$I_{DSS,min}$
600V	150 Ω	100mA

Applications

- Normally-on Switches
- SMPS Start-up Circuit
- Linear Amplifier
- Converters
- Constant Current Source
- Telecom

SOT-223





Ordering Information

Part Number	Package	Marking	Remark
DMS6014E	SOT-223	6014	Halogen Free

Absolute Maximum Ratings

T_A=25℃ unless otherwise specified

Symbol	Parameter	DMS6014E	Unit
V_{DSX}	Drain-to-Source Voltage[1]	600	V
V_{DGX}	Drain-to-Gate Voltage[1]	600	V
I_D	Continuous Drain Current	0.08	A
I_{DM}	Pulsed Drain Current[2]	0.32	
P_D	Power Dissipation	1.50	W
V_{GS}	Gate-to-Source Voltage	±20	V
T_L	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	℃
T_J and T_{STG}	Operating and Storage Temperature Range	-55 to 150	

Caution: Stresses greater than those listed in the"Absolute Maximum Ratings" may cause permanent damage to the device.

Thermal Characteristics

Symbol	Parameter	DMS6014E	Unit
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	83	K/W

Electrical Characteristics

OFF Characteristics

T_A =25℃ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
BV_{DSX}	Drain-to-Source Breakdown Voltage	600	--	--	V	V_{GS}=-5V, I_D=250μA
$I_{D(OFF)}$	Drain-to-Source Leakage Current	--	--	1	μA	V_{DS}=600V，V_{GS}= -5V
		--	--	100	μA	V_{DS}=600V，V_{GS}= -5V T_J=125℃
I_{GSS}	Gate-to-Source Leakage Current	--	--	20	uA	V_{GS}=+20V, V_{DS}=0V
		--	--	-20		V_{GS}=-20V, V_{DS}=0V

ON Characteristics

T_A =25℃ unless otherwise specified

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
I_{DSS}	Saturated Drain-to-Source Current	100	--	--	mA	V_{GS}=0V, V_{DS}=25V
$R_{DS(ON)}$	Static Drain-to-Source On-Resistance	--	110	150	Ω	V_{GS}=0V，I_D=50mA [3]
$V_{GS(OFF)}$	Gate-to-Source Cut-off Voltage	-3.3	--	-1.5	V	V_{DS} =3V, I_D=8μA
gfs	Forward Transconductance	--	77	--	mS	V_{DS} =10V, I_D=5mA

Dynamic Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
C_{ISS}	Input Capacitance	--	62	--	pF	V_{GS}=-5V V_{DS}=25V f=1.0MHz
C_{OSS}	Oput Capacitance	--	13	--		
C_{RSS}	Reverse Transfer Capacitance	--	9	--		
Q_G	Total Gate Charge	--	8	--	nC	V_{GS}=-5V~5V V_{DS}=300V, I_D=7mA
Q_{GS}	Gate-to-Source Charge	--	0.6	--		
Q_{GD}	Gate-to-Drain (Miller) Charge	--	3	--		

Resistive Switching Characteristics

Essentially independent of operating temperature

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions
$t_{d(ON)}$	Turn-on Delay Time	--	10	--	ns	V_{GS} = -5V~5V V_{DD} = 300V, I_D=7mA R_G = 20Ω
t_{rise}	Rise Time	--	22	--		
$t_{d(OFF)}$	Turn-off Delay Time	--	35	--		
t_{fall}	Fall Time	--	210	--		

Source-Drain Diode Characteristics

T_A=25℃ unless otherwise specified

Symbol	Parameter	Min	Typ.	Max.	Units	Test Conditions
V_{SD}	Diode Forward Voltage	--	--	1.2	V	I_{SD} =100 mA, V_{GS} = -10 V

NOTE：

[1] T_J=+25℃ to +150℃
[2] Repetitive rating, pulse width limited by maximum junction temperature.
[3] Pulse width≤380μs; duty cycle≤2%.

Typical Characteristics

Figure 1. Maximum Power Dissipation vs. Case Temperature

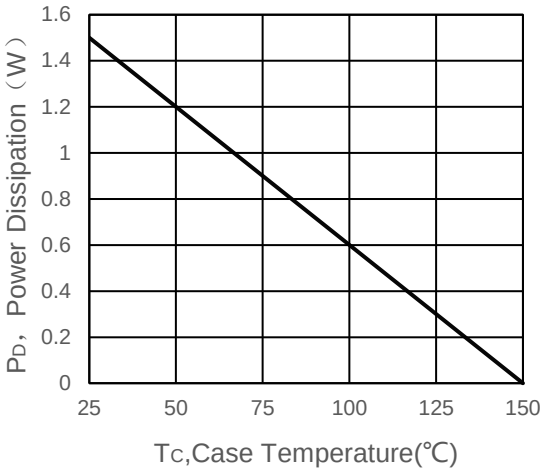


Figure 2. Maximum Continuous Drain Current vs. Case Temperature

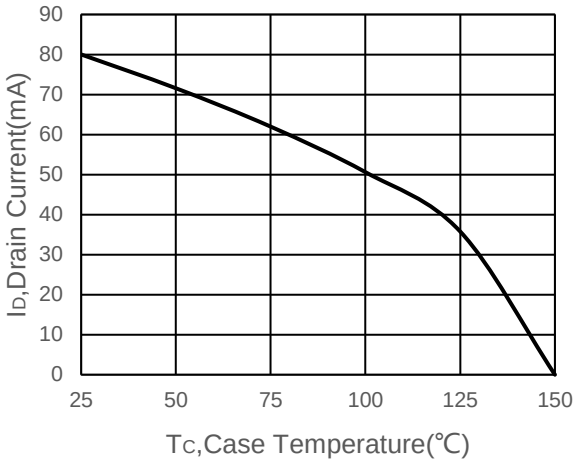


Figure 3.Typical Output Characteristics

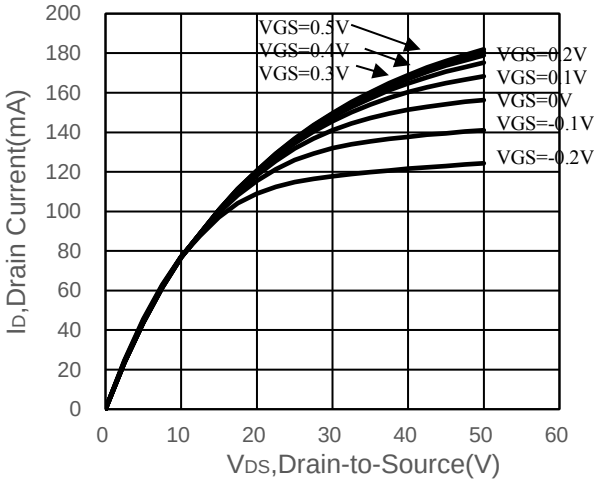


Figure 4. Typical Transfer Characteristics

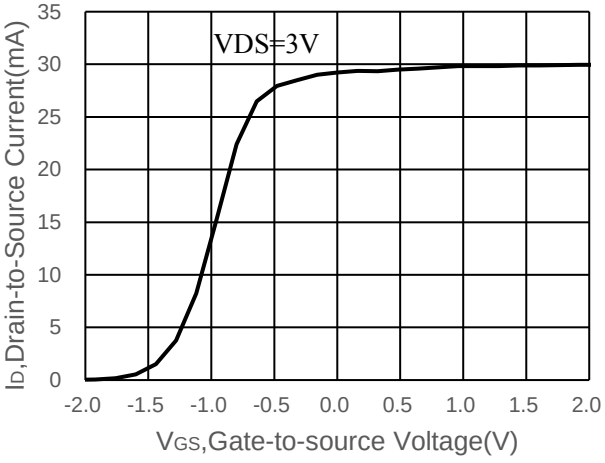


Figure 5. Typical Capacitance vs. Drain-to-Source Voltage

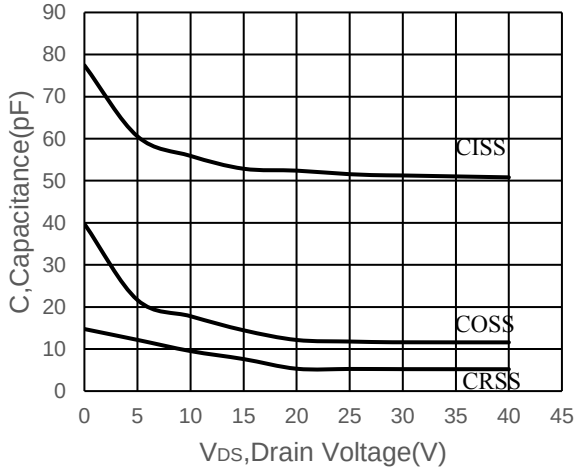
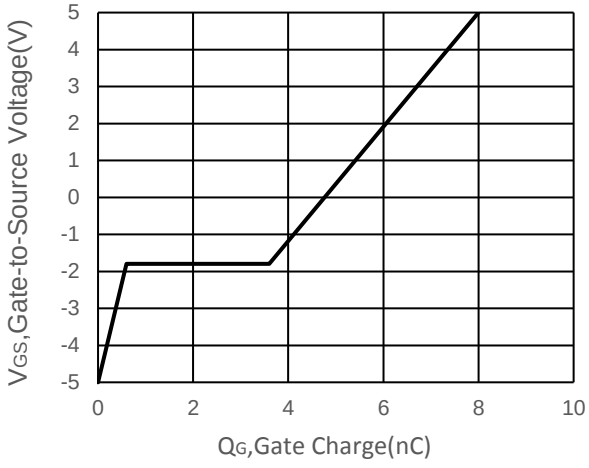
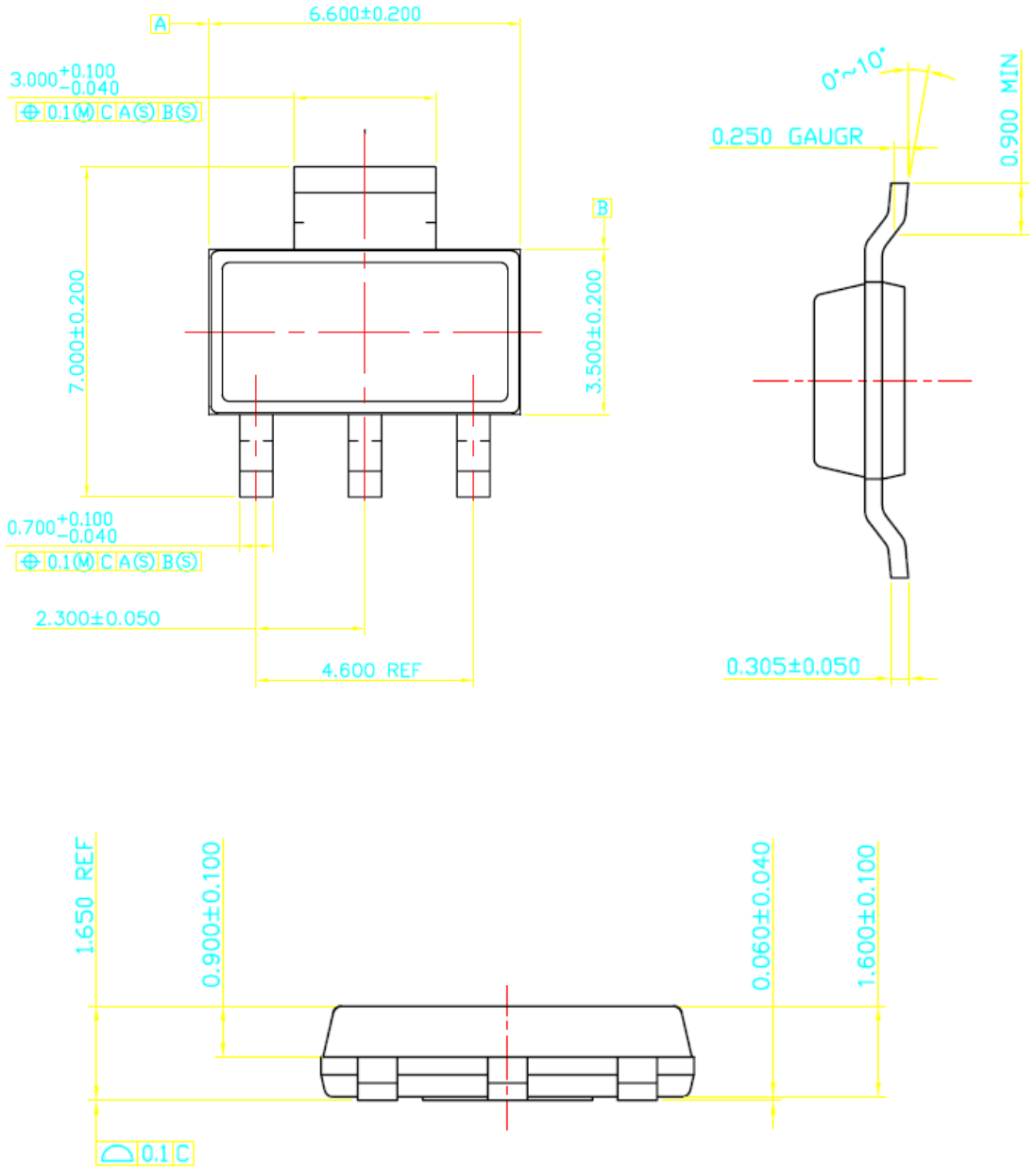


Figure 6. Typical Gate Charge vs. Gate-to-Source Voltage



Package Dimensions

SOT-223



Published by
ARK Microelectronics Co., Ltd.
ADD: D26,UESTC National Science Park No. 1 Shuangxing Avenue, Chengdu, Sichuan.

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